

<b>Notice of References Cited</b>	Application/Control No. 10/730,077	Applicant(s)/Patent Under Reexamination SAWAI ET AL.	
	Examiner Susan S. Lee	Art Unit 2852	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,138,396	08-1992	Satou et al.	399/316
*	B	US-6,198,903	03-2001	Benedict, Lawrence R.	399/316
*	C	US-6,097,925	08-2000	Nagaoka et al.	399/316
*	D	US-6,070,047	05-2000	Ichinose et al.	399/313
*	E	US-6,055,395	04-2000	Hiramoto, Yoshiaki	399/316
*	F	US-5,923,921	07-1999	OuYang et al.	---/---
*	G	US-5,552,873	09-1996	Hirao et al.	---/---
*	H	US-5,126,796	06-1992	Fujii et al.	399/297
*	I	US-4,839,697	06-1989	Kamitamari et al.	399/316
*	J	US-4,544,262	10-1985	Kanemitsu et al.	399/316
	K	US-6,516,179 B1	02-2003	Sawai et al.	399/316
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	Jp 9-311563a	12-1997	Japan	Sato	----/---
*	O	Jp 2000-155481	06-2000	Japan	Hayama	----/---
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.